MPQ1923-AEC1



100V, 8A, High-Frequency, Half-Bridge Gate Driver, AEC-Q100 Qualified

DESCRIPTION

The MPQ1923-AEC1 is a high-frequency, N-channel MOSFET, half-bridge gate driver. The device's low-side MOSFET (LS-FET) and high-side MOSFET (HS-FET) driver channels are controlled independently, and are matched with <5ns in time delay.

In the case of an insufficient supply, the device's HS-FET and LS-FET under-voltage lockout (UVLO) protection forces the outputs low. The MPQ1923-AEC1 also features an integrated bootstrap (BST) diode to reduce the external component count.

The MPQ1923-AEC1 is available in QFN-10 (4mmx4mm) and QFN-8 (4mmx4mm) packages.

FEATURES

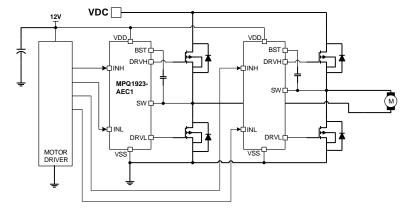
- Drives an N-Channel MOSFET Half-Bridge
- Low Dropout with 4.5V Under-Voltage Lockout (UVLO) Falling Threshold
- 120V Bootstrap Voltage (V_{BST}) Range
- On-Chip Bootstrap Diode
- 20ns Typical Propagation Delay
- 8A Sink Current, 7A Source Current at 12V
 VDD
- <5ns Gate Driver Matching Time Delay
- Drives a 1nF Load with 7.2ns Rise Time (t_{RISE}) and 5.5ns Fall Time (t_{FALL}) at 12V V_{DD}
- TTL-Compatible Input
- <300µA Quiescent Current (I_Q)
- UVLO Protection for the HS-FET and LS-FET Gate Drivers
- Available in QFN-10 (4mmx4mm) and QFN-8 (4mmx4mm) Packages
- Available in AEC-Q100 Grade 1

APPLICATIONS

- Motor Drivers
- Telecom Half-Bridge Power Supplies
- Avionics DC/DC Converters
- Two-Switch Forward Converters
- Active-Clamp Forward Converters

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TYPICAL APPLICATION





ORDERING INFORMATION

Part Number*	Package	Top Marking	MSL Rating
MPQ1923GRE-AEC1	QFN-10 (4mmx4mm)	See Below	1
MPQ1923GR-AEC1	QFN-8 (4mmx4mm)	See Below	1

^{*} For Tape & Reel, add suffix -Z (e.g. MPQ1923GRE-AEC1-Z).

TOP MARKING

MPSYWW MP1923 LLLLLL E

MPS: MPS prefix Y: Year code WW: Week code MP1923: Part number LLLLL: Lot number E: MPQ1923GRE-AEC1

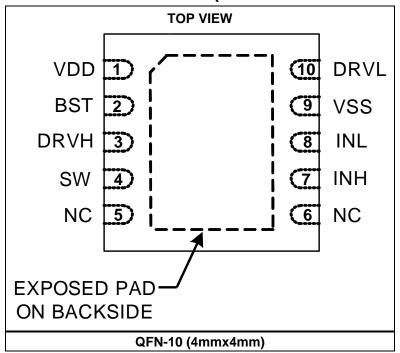
TOP MARKING

MPSYWW MP1923 LLLLLL

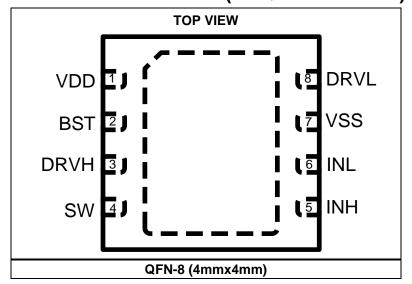
MPS: MPS prefix Y: Year code WW: Week code MP1923: Part number LLLLL: Lot number



PACKAGE REFERENCE (MPQ1923GRE-AEC1)



PACKAGE REFERENCE (MPQ1923GR-AEC1)





PIN FUNCTIONS

Pir	า #	Nome	Decayintian
QFN-10	QFN-8	Name	Description
1	1	VDD	Supply voltage. The VDD pin supplies power to the internal circuitry. Connect a decoupling capacitor between VDD and ground to ensure a stable and clean supply.
2	2	BST	Bootstrap. The BST pin is the positive power supply for the internal floating high-side MOSFET (HS-FET) driver. Connect a bypass capacitor between the BST and SW pins.
3	3	DRVH	Floating HS-FET driver output.
4	4	SW	Switching node.
5, 6		NC	Not connected.
7	5	INH	Control signal input for the floating HS-FET driver.
8	6	INL	Control signal input for the LS-FET driver.
9	7	VSS	Chip ground.
10	8	DRVL	LS-FET driver output.
Pad	Pad	Exposed pad	Exposed pad. Connect the exposed pad to the VSS pin to improve thermal operation.

ABSOLUTE MAXIMUM RATINGS (1)

Supply voltage (V _{DD})	0.3V to +18V
SW voltage (V _{SW})	5V to +120V
V _{SW} (<2µs)	18V to +120V
BST voltage (V _{BST})	0.3V to +120V
BST to SW	0.3V to +18V
DRVH voltage (V _{DRVH})	
V _{SW} -	$0.3V$ to $V_{BST} + 0.3V$
V _{DRVH} (<2µs)V _{SW}	$-2V$ to $V_{BST} + 0.3V$
DRVL voltage (V _{DRVL})	$-0.3V$ to $V_{DD} + 0.3V$
V _{DRVL} (<2µs)	
All other pins to VSS	0.3V to +10V
Continuous power dissipation	
QFN-10 (4mmx4mm)	2.66W
QFN-8 (4mmx4mm)	2.66W
Junction temperature	150°C
Lead temperature	260°C
Storage temperature	

ESD Ratings

Human body model (HE	3M)	±2000V
Charged device model ((CDM))±500V

Recommended Operating Conditions (3)

Supply voltage (V _{DD})	5V to 17V
SW voltage (V _{SW})	1V to +100V
SW slew rate	<50V/ns
Operating junction temp (T ₁)	-40°C to +125°C

Thermal Resistance (4)	$oldsymbol{ heta}_{JA}$	$\boldsymbol{\theta}$ JC	
QFN-10 (4mmx4mm)	47	7	.°C/W
QFN-8 (4mmx4mm)	47	7	.°C/W

Notes:

- 1) Exceeding these ratings may damage the device.
- 2) The maximum allowable power dissipation is a function of the maximum junction temperature T_J (MAX), the junction-to-ambient thermal resistance θ_{JA} , and the ambient temperature T_A . The maximum allowable continuous power dissipation at any ambient temperature is calculated by P_D (MAX) = $(T_J$ (MAX) $T_A)$ / θ_{JA} . Exceeding the maximum allowable power dissipation can produce an excessive die temperature, which may cause the device to go into thermal shutdown. Internal thermal shutdown circuitry protects the device from permanent damage.
- The device is not guaranteed to function outside of its operating conditions.
- 4) Measured on JESD51-7, 4-layer PCB.



ELECTRICAL CHARACTERISTICS

 V_{DD} = V_{BST} - V_{SW} = 12V, V_{SS} = V_{SW} = 0V, no load at DRVH and DRVL, T_A = -40°C to 125°C, unless otherwise noted.

Parameter	Symbol	Condition	Min	Тур	Max	Units		
Supply Currents								
VDD quiescent current	I_{DD_Q}	V _{INL} = V _{INH} = 0V		130	300	μΑ		
VDD operating current	I_{DD_OP}	$f_{SW} = 500kHz, C_{LOAD} = 0nF$		2.6	6	mA		
Floating driver quiescent current	I _{BST_Q}	VINL = VINH = 0V		60	150	μA		
Floating driver operating current	I _{BST_OP}	fsw = 500kHz, C _{LOAD} = 0nF		2.6	6	mA		
BST to VSS quiescent current	I _{BST-SS_Q}	$V_{BST} = V_{SW} = 115V$		0.05	1	μA		
BST to VSS operating current	I _{BST-SS_OP}	fsw = 500kHz, C _{LOAD} = 0nF		2.3	5.5	mA		
Leakage current	I_{LKG}	$V_{BST} = V_{SW} = 100V$		0.05	1	μA		
Inputs								
INL and INH high voltage				2	2.4	V		
INL and INH low voltage			0.8	1.2		V		
Input voltage hysteresis				600		mV		
INL and INH internal pull-down	RINL			155		kΩ		
resistance	RINH			155		kΩ		
Under-Voltage Protection (UV	LO) Protection	n						
VDD rising threshold	V _{DD_RISING}		4.6	5	5.4	V		
VDD falling threshold	V _{DD_FALLING}		4.1	4.5	4.9	V		
(BST - SW) rising threshold	V _{BST_RISING}		1.6	3.7	4.9	V		
(BST - SW) falling threshold	$V_{BST_FALLING}$		1.4	3.2	4.6	V		
Bootstrap Diode								
Bootstrap diode VF at 100µA	V_{F1}			0.5	0.9	V		
Bootstrap diode VF at 100mA	V _{F2}			1	1.2	V		
Bootstrap diode dynamic R	R₀	I _{VDD-BST} = 100mA and 80mA		3.1	6.5	Ω		
Low-Side MOSFET (LS-FET) G	ate Driver				•			
Low-level output voltage	Voll	I _{OUT} = 100mA	0.02	0.07	0.2	V		
High-level output voltage to rail	Vohl	I _{ОUТ} = -100mA	0.02	0.07	0.3	V		
Source current (5)	I _{OHL}	$V_{DRVL} = 0V, V_{DD} = 12V$		7		Α		
Course current	IOHL	$V_{DRVL} = 0V$, $V_{DD} = 16V$		9		Α		
Sink current (5)	loll	$V_{DRVL} = V_{DD} = 12V$		8		Α		
	_	$V_{DRVL} = V_{DD} = 16V$		10		Α		
Floating High-Side MOSFET (I			1	1	1	1		
Low level output voltage	Volh	I _{OUT} = 100mA	0.02	0.07	0.2	V		
High level output voltage to rail	Vонн	I _{OUT} = -100mA	0.02	0.07	0.3	V		
Source current (5)	I _{OHH}	$V_{DRVH} = 0V$, $V_{DD} = 12V$		7		Α		
Course carrein	101111	$V_{DRVH} = 0V, V_{DD} = 16V$		9		Α		
Sink current (5)	lolh	$V_{DRVH} = V_{DD} = 12V$		8		Α		
		$V_{DRVH} = V_{DD} = 16V$		10		Α		
Switching Specifications (LS-FET Gate Driver)								
Turn-off propagation delay	tolff	C _{LOAD} = 0nF, INL falling to DRVL falling	5	20	50	ns		
Turn-on propagation delay	t dlrr	C _{LOAD} = 0nF, INL rising to DRVL rising	5	20	50	ns		
DRVL rise time	tous- : s	C _{LOAD} = 1nF, from 10% to 90%		7.2		ns		
DIVVE HSE WHE	t _{RISE_LS}	C _{LOAD} = 0.1µF, from 3V to 9V		0.2	0.6	μs		



ELECTRICAL CHARACTERISTICS (continued)

 $V_{DD} = V_{BST} - V_{SW} = 12V$, $V_{SS} = V_{SW} = 0V$, no load at DRVH and DRVL, $T_A = -40^{\circ}C$ to 125°C, unless otherwise noted.

Parameter	Symbol	Condition	Min	Тур	Max	Units
DRVL fall time	4	C _{LOAD} = 1nF, from 90% to 10%		5.5		ns
DRVL fall time	t fall_ls	C _{LOAD} = 0.1µF, from 9V to 3V		0.15	0.4	μs
Switching Specifications (Floa	ating HS-FE	ET Gate Driver)				
Turn-off propagation delay	tohff	C _{LOAD} = 0nF, INH falling to DRVH falling	5	20	50	ns
Turn-on propagation delay	tohrr	C _{LOAD} = 0nF, INH rising to DRVH rising	5	20	50	ns
DD\/H rice time	4	C _{LOAD} = 1nF, from 10% to 90%		7.2		ns
DRVH rise time	trise_Hs	$C_{LOAD} = 0.1 \mu F$, (3V to 9V)		0.2	0.6	μs
DD\/H fall time	4	C _{LOAD} = 1nF, from 90% to 10%		5.5		ns
DRVH fall time	t _{FALL_} HS	$C_{LOAD} = 0.1 \mu F$, (9V to 3V)		0.15	0.4	μs
Switching Specifications (Mat	ching)					
HS-FET driver turn-off to LS- FET driver turn-on time (5)	t _{MON}			1	5	ns
LS-FET driver turn-off to HS- FET driver turn-on time (5)	tmoff			1	5	ns
Minimum input pulse width to change the output (5)	t _{PW}				50	ns
Bootstrap (BST) diode turn-on or turn-off time (5)	t BST			10		ns
Thermal shutdown				165		°C
Thermal shutdown hysteresis				25		°C

Note:

5) Guaranteed by design.

TIMING DIAGRAM

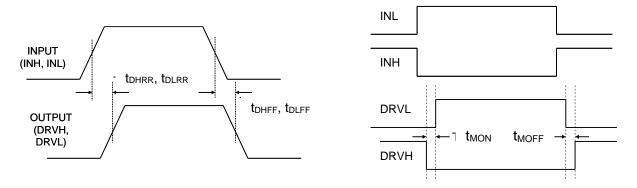
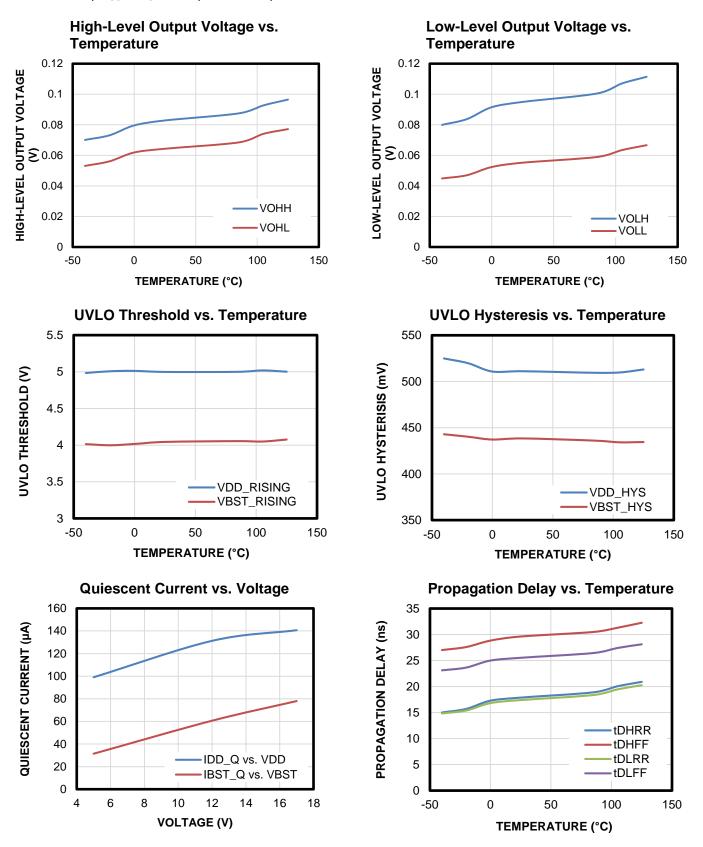


Figure 1: Timing Diagram



TYPICAL CHARACTERISTICS

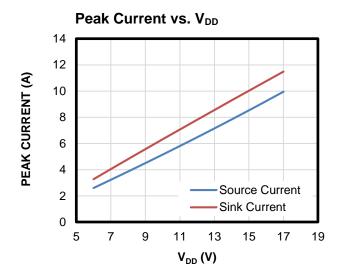
 $V_{DD} = 12V$, $V_{SS} = V_{SW} = 0V$, $T_A = 25$ °C, unless otherwise noted.

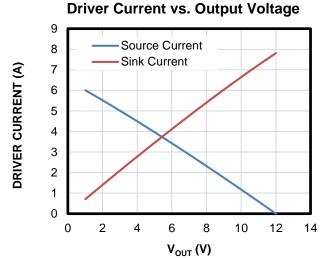




TYPICAL CHARACTERISTICS (continued)

 V_{DD} = 12V, V_{SS} = V_{SW} = 0V, T_A = 25°C, unless otherwise noted.





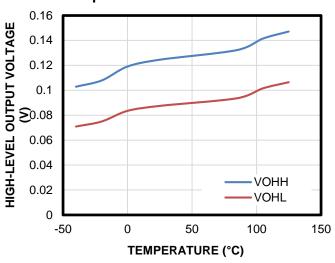
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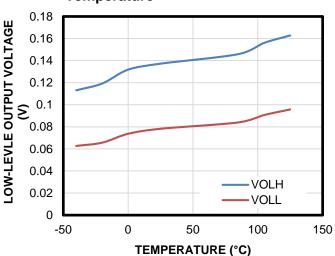
TYPICAL CHARACTERISTICS (continued)

 $V_{DD} = 5V$, $V_{SS} = V_{SW} = 0V$, $T_A = 25$ °C, unless otherwise noted.

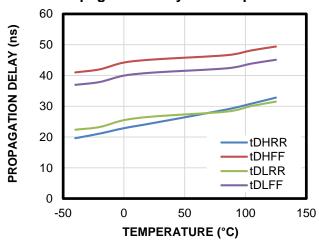
High-Level Output Voltage vs. **Temperature**



Low-Level Output Voltage vs. **Temperature**



Propagation Delay vs. Temperature



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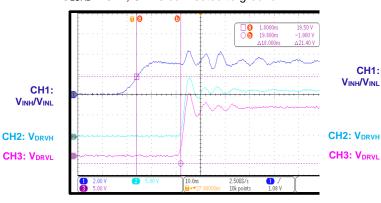


TYPICAL PERFORMANCE CHARACTERISTICS

 $V_{DD} = 12V$, $V_{SS} = V_{SW} = 0V$, $T_A = 25$ °C, unless otherwise noted.

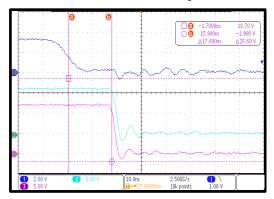
Turn-On Propagation Delay

CLOAD = 0nF, SW is connected to ground



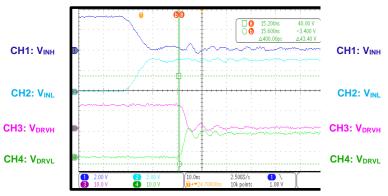
Turn-Off Propagation Delay

CLOAD = 0nF, SW is connected to ground



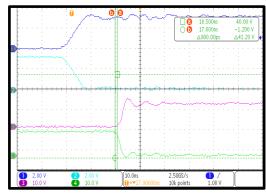
Gate Driver Matching (t_{MON})

CLOAD = OnF, SW is connected to ground



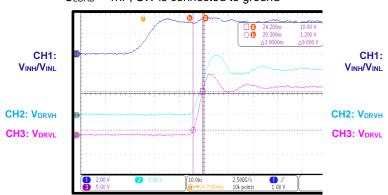
Gate Driver Matching (t_{MOFF})

CLOAD = OnF, SW is connected to ground



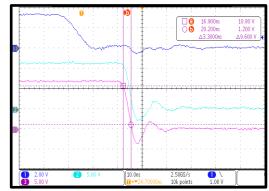
Gate Driver Rise Time

CLOAD = 1nF, SW is connected to ground



Gate Driver Fall Time

C_{LOAD} = 1nF, SW is connected to ground



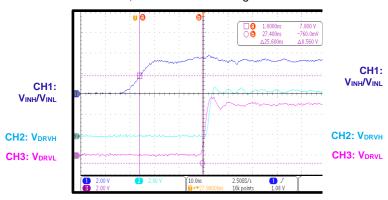


TYPICAL PERFORMANCE CHARACTERISTICS (continued)

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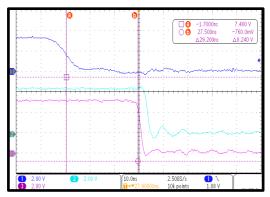
Turn-On Propagation Delay

CLOAD = 0nF, SW is connected to ground



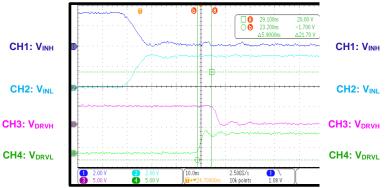
Turn-Off Propagation Delay

C_{LOAD} = 0nF, SW is connected to ground



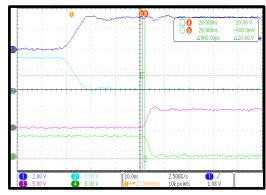
Gate Driver Matching (t_{MON})

CLOAD = OnF, SW is connected to ground



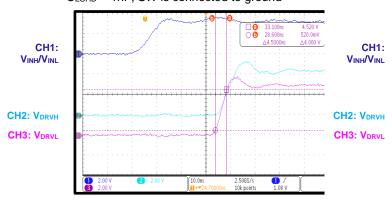
Gate Driver Matching (t_{MOFF})

CLOAD = 0nF, SW is connected to ground



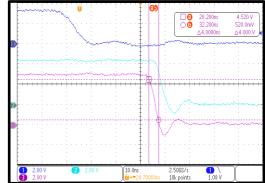
Gate Driver Rise Time

C_{LOAD} = 1nF, SW is connected to ground



Gate Driver Fall Time

C_{LOAD} = 1nF, SW is connected to ground





FUNCTIONAL BLOCK DIAGRAM

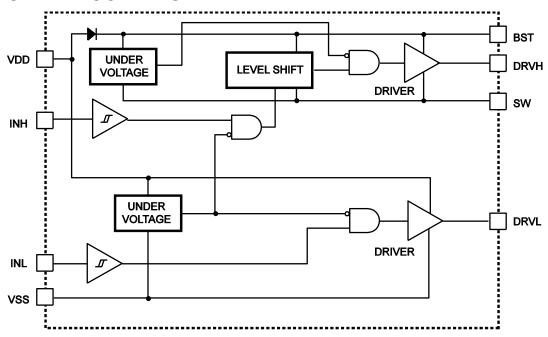


Figure 2: Functional Block Diagram



REFERENCE DESIGN CIRCUITS

Half-Bridge Converter

In a half-bridge converter topology, the high-side MOSFET (HS-FET) and low-side MOSFET (LS-FET) are driven alternately with a dead time (DT) inserted between their respective on periods. INT and INL are driven with alternating signals via the pulse-width modulation (PWM) controller. The input voltage (V_{IN}) can rise up to 100V when in a half-bridge topology (see Figure 5 in the Typical Application Circuits section on page 16).

Two-Switch Forward Converter

In a two-switch forward converter topology, the HS-FET and LS-FET start up and shutdown simultaneously. During current-mode control, the INH and INL input signals sense the output voltage (V_{OUT}) and output current (I_{OUT}) via a

PWM controller. The Schottky diodes clamp the power transformer's reverse swing, and should be rated for V_{IN} , which can rise up to 100V (see Figure 6 in the Typical Application Circuits section on page 16).

Active-Clamp Forward Converter

In an active-clamp forward converter topology, the HS-FET and LS-FET are driven alternately. The HS-FET and the reset capacitor (C_{RESET}) reset the power transformer without loss.

Active-clamp forward converter topologies are optimal for duty cycles exceeding 50%. The MPQ1923-AEC1 may not be able to operate at 100V in an active-clamp forward topology (see Figure 7 in the Typical Application Circuits section on page 16).



APPLICATION INFORMATION

The INH and INL input signals can be controlled independently. If both INH and INL control the HS-FET and LS-FET of the same bridge, set a sufficient DT between the low INH and INL signals (and vice versa) to avoid shoot-through. DT is the time interval between low INH and low INL. Figure 3 shows the shoot-through timing diagram.

PCB Mounting

To comply with IPC-2221 or IPC-9592 standards, conformal coating is required after mounting the device on the PCB.

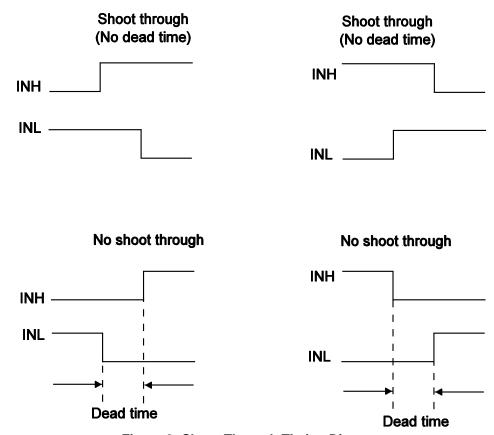


Figure 3: Shoot-Through Timing Diagram



PCB Layout Guidelines

Efficient PCB layout is critical for stable operation. The MPQ1923-AEC1 is designed to accommodate negative undershoot; however, excessive undershoot can lead to unpredictable operation or damage to the IC. For the best results, refer to Figure 4 and follow the guidelines below:

- Connect the HS-FET source and the LS-FET drain using a short and direct trace to avoid negative undershoot on the phase node due to parasitic inductance.
- 2. Use surface-mount N-channel MOSFETs that allow for a very short connection between the HS-FETs and LS-FETs.
- 3. Place the bootstrap capacitor (C3) and the supply bypass capacitor (C2) as close to the IC as possible.
- Connect the ground side of C3 and C2 to both the GND pin and the exposed pad using multiple vias. The ground side of the capacitors are connected to a solid ground plane.

5. Route the high-current ground path between the input supply, the input bulk capacitor (C6), and the MOSFETs. Route this path away from the IC.

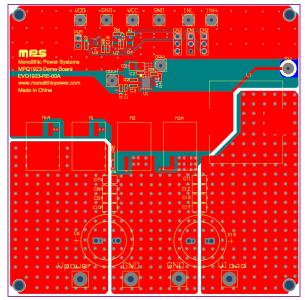


Figure 4: Recommended PCB Layout



TYPICAL APPLICATION CIRCUITS

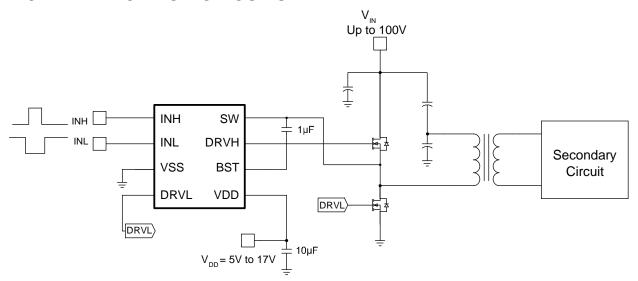


Figure 5: Typical Application Circuit (Half-Bridge Converter Topology)

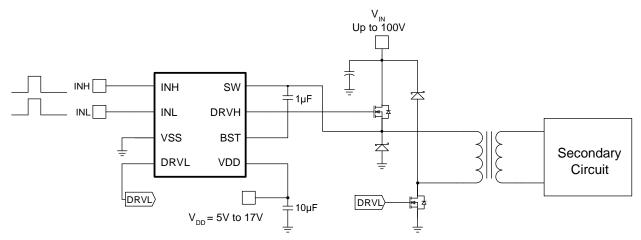


Figure 6: Typical Application Circuit (Two-Switch Forward Converter Topology)

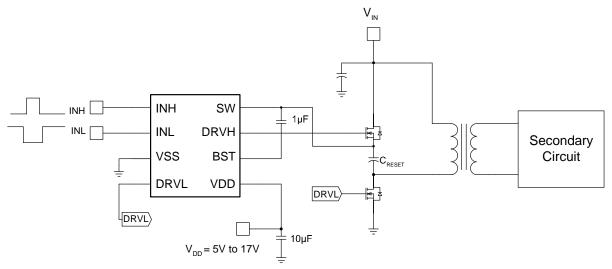


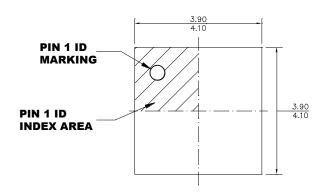
Figure 7: Typical Application Circuit (Active-Clamp Forward Converter Topology)

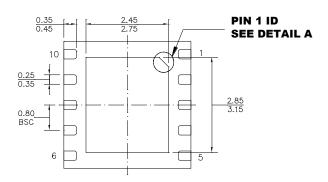
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PACKAGE INFORMATION

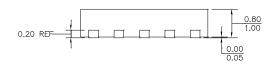
QFN-10 (4mmx4mm)





TOP VIEW

BOTTOM VIEW



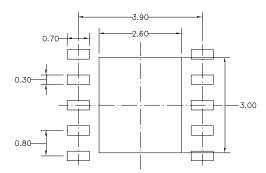
SIDE VIEW







DETAIL A



NOTE:

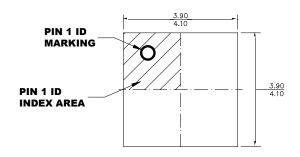
- 1) ALL DIMENSIONS ARE IN MILLIMETERS.
- 2) EXPOSED PADDLE SIZE DOES NOT INCLUDE MOLD FLASH.
- 3) LEAD COPLANARITY SHALL BE 0.10 MILLIMETERS MAX.
- 4) JEDEC REFERENCE IS MO-220.
- 5) DRAWING IS NOT TO SCALE.

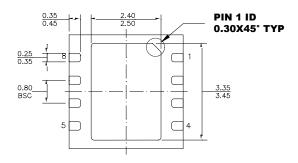
RECOMMENDED LAND PATTERN



PACKAGE INFORMATION (continued)

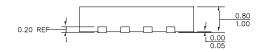
QFN-8 (4mmx4mm)



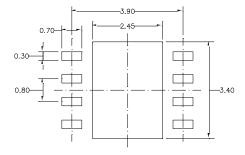


TOP VIEW

BOTTOM VIEW



SIDE VIEW



NOTE:

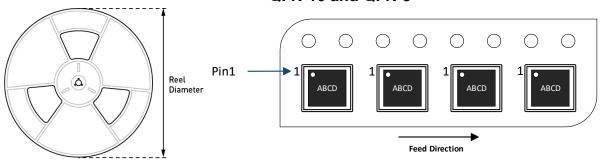
- 1) ALL DIMENSIONS ARE IN MILLIMETERS.
- 2) EXPOSED PADDLE SIZE DOES NOT INCLUDE MOLD FLASH.
- 3) LEAD COPLANARITY SHALL BE 0.08 MILLIMETERS MAX.
- 4) JEDEC REFERENCE IS MO-220.
- 5) DRAWING IS NOT TO SCALE.

RECOMMENDED LAND PATTERN



CARRIER INFORMATION

QFN-10 and QFN-8



Part Number	Package Description	Quantity/ Reel	Quantity/ Tube	Reel Diameter	Carrier Tape Width	Carrier Tape Pitch
MPQ1923GRE- AEC1-Z	QFN-10 (4mmx4mm)	5000	N/A	13in	12mm	8mm
MPQ1923GR- AEC1-Z	QFN-8 (4mmx4mm)	5000	N/A	13in	12mm	8mm



REVISION HISTORY

Revision #	Revision Date	Description	Pages Updated
1.0	8/19/2022	Initial Release	-
		Updated all headers with AEC-Q100; formatting updates	All
1.1 7/		Updated footers with MPQ1923-AEC1	All
	7/18/2023	Updated all mentions of MPQ1923 to MPQ1923-AEC1	
	1710/2023	Updated the Ordering Information sectionUpdated the Top Marking section	2
		Updated the Carrier Information section	19

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